

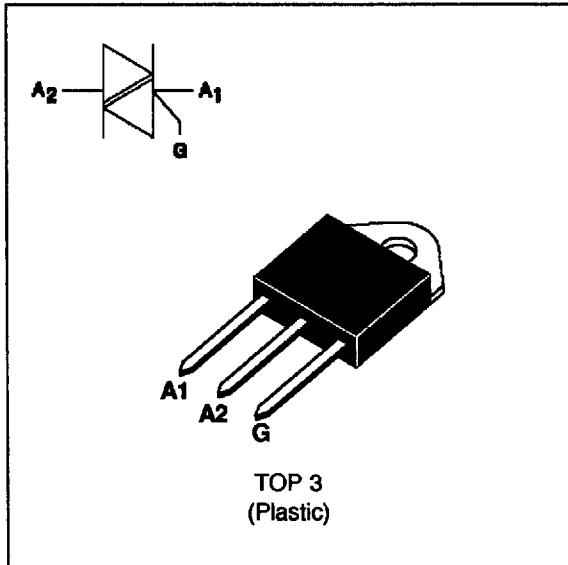
## SNUBBERLESS TRIACS

### FEATURES

- HIGH COMMUTATION :  $(dI/dt)_c > 22A/\mu s$  without snubber
- HIGH SURGE CURRENT :  $I_{TSM} = 250A$
- V<sub>DRM</sub> UP TO 800V
- BTA Family :
  - INSULATING VOLTAGE = 2500V(RMS)
  - (UL RECOGNIZED : E81734)

### DESCRIPTION

The BTA26 BW/CW triac family are high performance glass passivated chips technology. The SNUBBERLESS™ concept offer suppression of RC network and it is suitable for application such as phase control and static switching on inductive or resistive load.



### ABSOLUTE RATINGS (limiting values)

Symbol	Parameter	Value	Unit
$I_T(\text{RMS})$	RMS on-state current (360° conduction angle)	25	A
$I_{TSM}$	Non repetitive surge peak on-state current ( $T_j$ initial = 25°C )	$t_p = 8.3 \text{ ms}$	A
		$t_p = 10 \text{ ms}$	
$I^2t$	$I^2t$ value	312.5	$\text{A}^2\text{s}$
$dI/dt$	Critical rate of rise of on-state current Gate supply : $I_G = 500\text{mA}$ $dI_G/dt = 1\text{A}/\mu\text{s}$	20	$\text{A}/\mu\text{s}$
		100	
$T_{stg}$ $T_j$	Storage and operating junction temperature range	- 40 to + 150 - 40 to + 125	°C
$T_I$	Maximum lead temperature for soldering during 10 s at 4.5 mm from case	260	°C

Symbol	Parameter	BTA26... BW/CW				Unit
		400	600	700	800	
V <sub>DRM</sub> V <sub>RRM</sub>	Repetitive peak off-state voltage $T_j = 125^\circ\text{C}$	400	600	700	800	V

## THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
R <sub>th</sub> (j-a)	Junction to ambient	50	°C/W
R <sub>th</sub> (j-c) DC	Junction to case for DC	1.5	°C/W
R <sub>th</sub> (j-c) AC	Junction to case for 360° conduction angle (F= 50 Hz)	1.1	°C/W

## GATE CHARACTERISTICS (maximum values)

P<sub>G</sub> (AV) = 1W    P<sub>GM</sub> = 40W (t<sub>p</sub> = 20 μs)    I<sub>GM</sub> = 8A (t<sub>p</sub> = 20 μs)    V<sub>GM</sub> = 16V (t<sub>p</sub> = 20 μs).

## ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions	Quadrant	Suffix			Unit	
			BW	CW			
I <sub>GT</sub>	V <sub>D</sub> =12V (DC) R <sub>L</sub> =33Ω	T <sub>j</sub> =25°C	I-II-III	MIN	2	2	mA
				MAX	50	35	
V <sub>GT</sub>	V <sub>D</sub> =12V (DC) R <sub>L</sub> =33Ω	T <sub>j</sub> =25°C	I-II-III	MAX	1.5		V
V <sub>GD</sub>	V <sub>D</sub> =V <sub>DRM</sub> R <sub>L</sub> =3.3kΩ	T <sub>j</sub> =125°C	I-II-III	MIN	0.2		V
t <sub>gt</sub>	V <sub>D</sub> =V <sub>DRM</sub> I <sub>G</sub> = 500mA dI <sub>G</sub> /dt = 3A/μs	T <sub>j</sub> =25°C	I-II-III	TYP	2		μs
I <sub>L</sub>	I <sub>G</sub> =1.2 I <sub>GT</sub>	T <sub>j</sub> =25°C	I-III	TYP	50	-	mA
			II	TYP	90	-	
			I-II-III	MAX	-	80	
I <sub>H</sub> *	I <sub>T</sub> = 500mA gate open	T <sub>j</sub> =25°C		MAX	75	50	mA
V <sub>TM</sub> *	I <sub>TM</sub> = 35A t <sub>p</sub> = 380μs	T <sub>j</sub> =25°C		MAX	1.80		V
I <sub>DRM</sub> I <sub>RRM</sub>	V <sub>DRM</sub> Rated V <sub>RRM</sub> Rated	T <sub>j</sub> =25°C		MAX	0.01		mA
		T <sub>j</sub> =125°C		MAX	3		
dV/dt *	Linear slope up to V <sub>D</sub> =67%V <sub>DRM</sub> gate open	T <sub>j</sub> =125°C		MIN	500	250	V/μs
				TYP	750	500	
(dl/dt) <sub>c</sub> *	Without snubber	T <sub>j</sub> =125°C		MIN	22	13	A/ms
				TYP	44	26	

\* For either polarity of electrode A<sub>2</sub> voltage with reference to electrode A<sub>1</sub>.

## ORDERING INFORMATION

Package	$I_T(\text{RMS})$	$V_{\text{DRM}} / V_{\text{RRM}}$	Sensitivity Specification			
			A	V	BW	CW
BTA (Insulated)	25	400	X		X	
		600		X		X
		700		X		X
		800		X		X

Fig.1 : Maximum RMS power dissipation versus RMS on-state current ( $F=50\text{Hz}$ ).  
(Curves are cut off by  $(dI/dt)_c$  limitation)

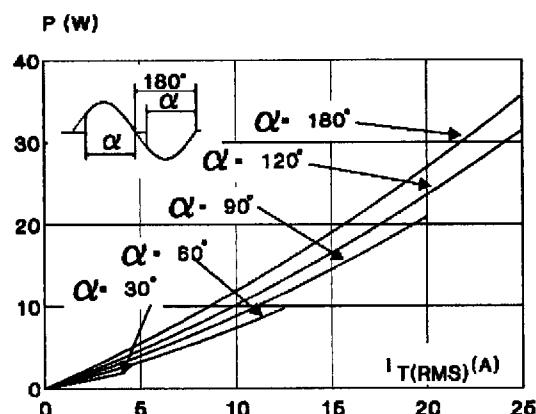


Fig.3 : RMS on-state current versus case temperature.

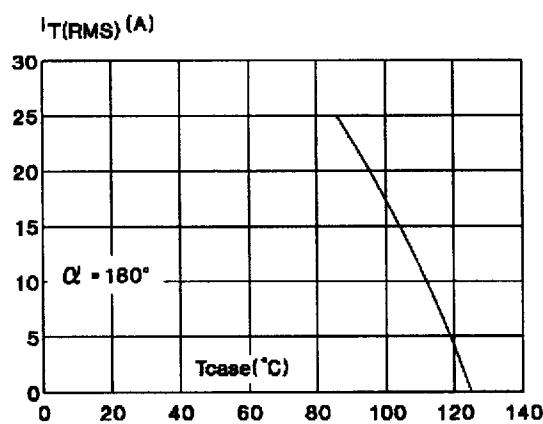


Fig.2 : Correlation between maximum RMS power dissipation and maximum allowable temperatures ( $T_{\text{amb}}$  and  $T_{\text{case}}$ ) for different thermal resistances heatsink + contact.

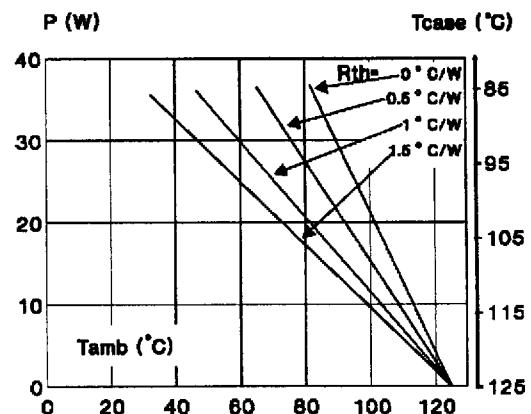
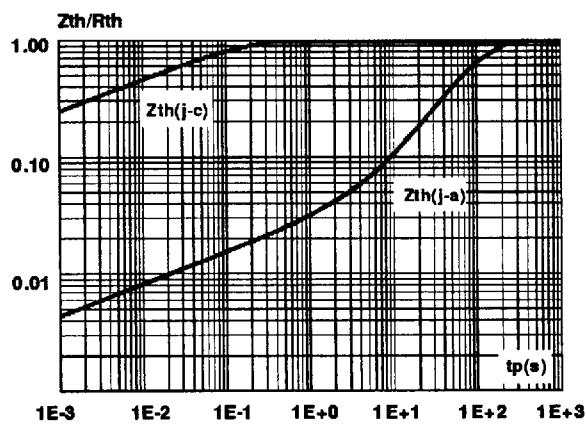
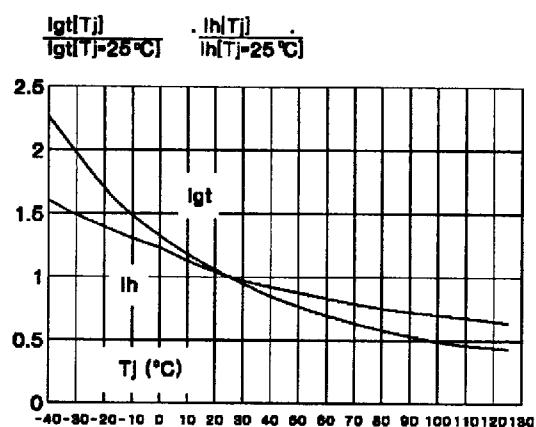


Fig.4 : Relative variation of thermal impedance versus pulse duration.

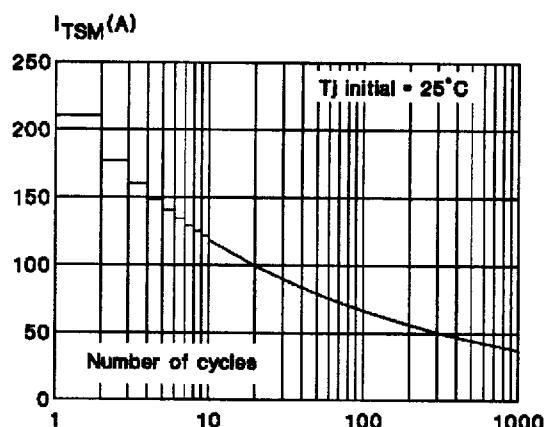


## BTA26 BW/CW

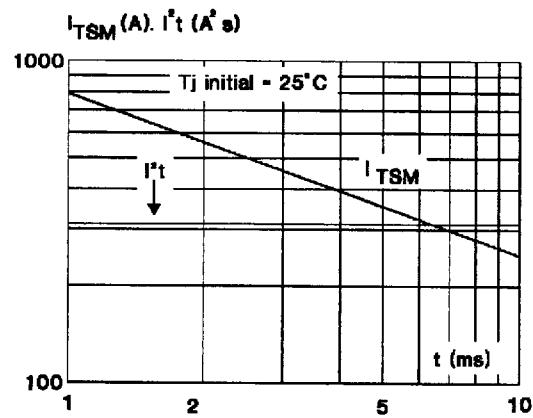
**Fig.5 :** Relative variation of gate trigger current and holding current versus junction temperature.



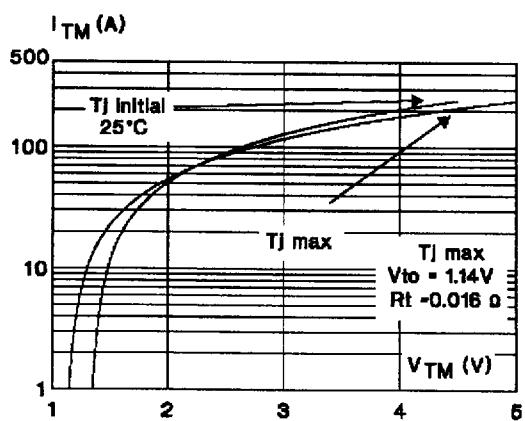
**Fig.6 :** Non Repetitive surge peak on-state current versus number of cycles.



**Fig.7 :** Non repetitive surge peak on-state current for a sinusoidal pulse with width :  $t \leq 10\text{ms}$ , and corresponding value of  $I^2t$ .



**Fig.8 :** On-state characteristics (maximum values).



## PACKAGE MECHANICAL DATA

TOP 3 Plastic

REF.	DIMENSIONS			
	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	15.10	15.50	0.594	0.611
B	20.70	21.10	0.814	0.831
C	14.30	15.60	0.561	0.615
D	16.10	16.50	0.632	0.650
G	3.40	-	0.133	-
H	4.40	4.60	0.173	0.182
I	4.08	4.17	0.161	0.164
J	1.45	1.55	0.057	0.062
L	0.50	0.70	0.019	0.028
M	2.70	2.90	0.106	0.115
N	5.40	5.65	0.212	0.223
P	1.20	1.40	0.047	0.056

Cooling method : C

Marking : type number

Weight : 4.7 g

Recommended torque value : 0.8 m.N.

Maximum torque value : 1 m.N.

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